

Search Notes

Application/Control No.

10/630,647

Examiner

Nhan T. Tran

Applicant(s)/Patent under
Reexamination

BECK ET AL.

Art Unit

2622

SEARCHED

Class	Subclass	Date	Examiner
348	308; 294	7/25/2007	NT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
PGPUB text search - see search history printout		7/30/2007	NT

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated EAST search (USPAT, PGPUB, JPO, EPO, DERWENT, IBM_TDB)	7/25/2007	NT
250/208.1 257/290-292 (text search - see search history printout)	7/25/2007	NT
348/294-324 (text search - see search history printout)	7/27/2007	NT
358/482-483, 513-514 (text search - see search history printout)	7/30/2007	NT
Text search all databases listed above	7/30/2007	NT
Inventorship search - see search history printout	7/30/2007	NT